## Notice of References Cited Application/Control No. 10/580,873 Applicant(s)/Patent Under Reexamination ARA PINILLA ET AL. Examiner DEVANIE DUFOUR 3733 Applicant(s)/Patent Under Reexamination ARA PINILLA ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-3,512,448	05-1970	JEAL HARVEY PHILIP et al.	411/53
*	В	US-4,227,518	10-1980	Aginsky, Jacob	606/63
*	С	US-4,467,793	08-1984	Ender, Hans G.	606/62
*	D	US-4,913,137	04-1990	Azer et al.	606/64
*	Е	US-5,135,527	08-1992	Ender, Hans G.	606/62
*	F	US-5,281,225	01-1994	Vicenzi, Guglielmo	606/62
*	G	US-5,281,224	01-1994	Faccioli et al.	606/62
*	Н	US-5,295,991	03-1994	Frigg, Robert	606/62
*	ı	US-5,443,466	08-1995	Shah, Mrugesh K.	606/62
*	J	US-2003/0149486 A1	08-2003	Huebner, Randall J.	623/19.11
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	V					
	w					
	х					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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